Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination				
10/748,342	DOMBROSKI ET AL.				
Examiner	Art Unit				
Anthony J. Paviglianiti	1626				

SEARCHED						
Class	Subclass	Date	Examiner			
548	263.2	5/31/2005	AJP			
514	384	6/1/2005	AJP			
548	324.1	6/7/2005	AJP	ļ.		
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INTERFERENCE SEARCHED					
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068	263,2	MI			
	374	1/0/18			
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Restriction required;	3/25/2005	AJP
CAPLUS - structure search of elected compound (Example 12 in Specification, p. 68);	5/31/2005	AJP
CAPLUS USPATFULL - text search triazoles with benzamide and with or without cycloheptanyl;	5/31/2005	AJP
CAPLUS - broaden structure search to 1,2,4-triazole ring bonded to benzamide group;	5/31/2005	AJP
CAPLUS - broaden structure search to imidazole ring bonded to benzamide group;	5/31/2005	AJP
EAST text search - 1,2,4-triazole or imidazole with benzamide and oxo substituents;	5/31/2005	AJP
PALM - Inventor search (Mark Dombroski; Allen Duplantier; Chakrapani Subramanyam);	6/6/2005	AJP
EAST - text search benzamide derivatives as P2X7 receptor inhibitors;	6/6/2005	AJP

Search Notes (continued)		Application/Control No. 10/748,342 Examiner		Applicant(s)/Patent under Reexamination					
				DOMBROSKI ET AL. Art Unit					
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0,033	0000833	0410	Calline				DATE	EXMR	
					PUBMED - structure-activity relationships (ortho vs para substituents on benzene ring) finhibition of P2X7 receptors;		6/6/2005	AJP	
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Application/Control No.

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